



钜地半导体
Tudi Semiconductor

Product Specification

TUDI-LM239AQDRQ1

QUAD DIFFERENTIAL COMPARATOR

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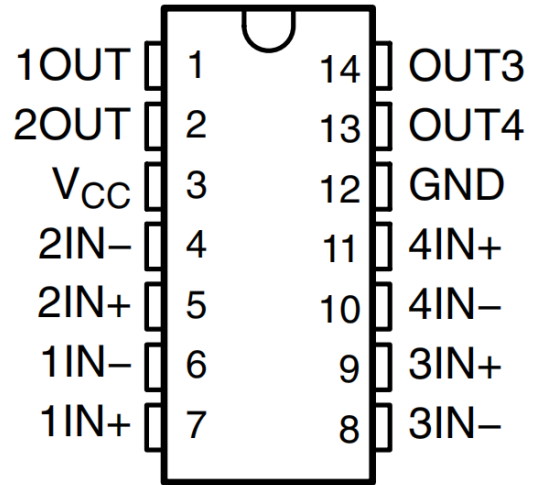
**semiconductor device
manufacturer**

- Design
- research and development
- production
- and sales



FEATURES

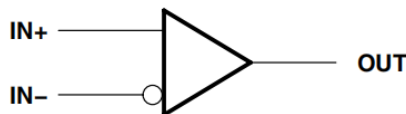
- Qualified for Automotive Applications
- ESD Protection Exceeds 1000 V Per MIL-STD-883, Method 3015; Exceeds 100 V Using Machine Model (C = 200 pF, R = 0); Exceeds 2000 V Charged Device Model
- Single Supply or Dual Supplies
- Wide Range of Supply Voltage . . . 2 V to 36 V
- Low Supply-Current Drain Independent of Supply Voltage . . . 0.8 mA Typ
- Low Input Bias Current . . . 25 nA Typ
- Low Input Offset Current . . . 5 nA Typ
- Low Input Offset Voltage . . . 2 mV Typ
- Common-Mode Input Voltage Range Includes Ground
- Differential Input Voltage Range Equal to Maximum-Rated Supply Voltage . . . ± 36 V
- Low Output Saturation Voltage
- Output Compatible With TTL, MOS, and CMOS



DESCRIPTION

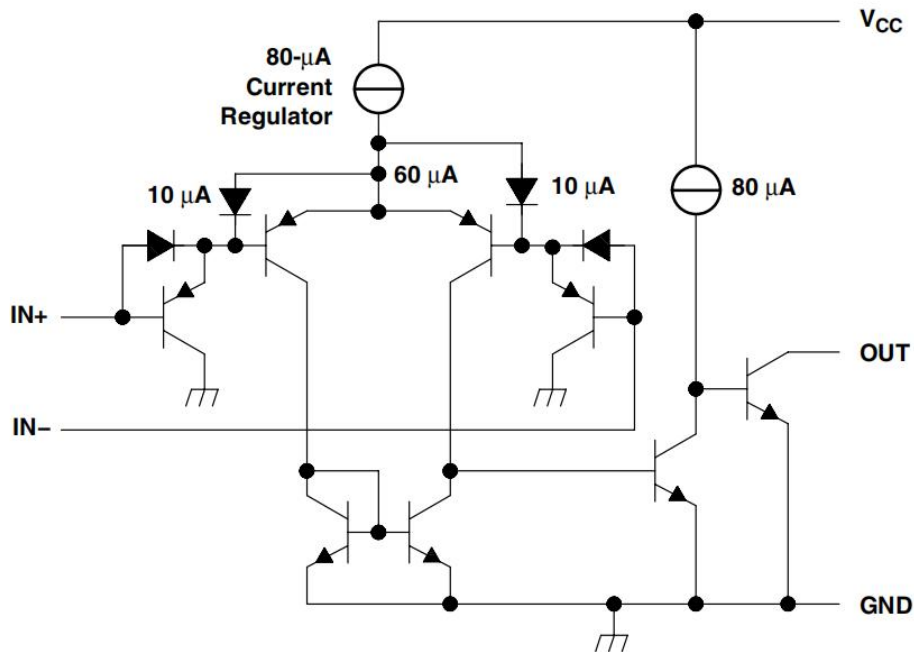
This device consists of four independent voltage comparators that are designed to operate from a single power supply over a wide range of voltages. Operation from dual supplies also is possible as long as the difference between the two supplies is 2 V to 36 V, and VCC is at least 1.5 V more positive than the input common-mode voltage. Current drain is independent of the supply voltage. The outputs can be connected to other open-collector outputs to achieve wired-AND relationships.

symbol (each comparator)





schematic (each comparator)



All current values shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage, V_{CC} (see Note 1)	36 V
Differential input voltage, V_{ID} (see Note 2)	± 36 V
Input voltage range, V_I (either input)	-0.3 V to 36 V
Output voltage, V_O	36 V
Output current, I_O	20 mA
Duration of output short circuit to ground (see Note 3)	Unlimited
Package thermal impedance, θ_{JA} (see Note 4)	86°C/W
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C
Maximum operating junction temperature, T_J	136°C
Storage temperature range, T_{stg}	-65°C to 150°C

[†] Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES:
1. All voltage values, except differential voltages, are with respect to network ground.
 2. Differential voltages are at $IN+$ with respect to $IN-$.
 3. Short circuits from outputs to V_{CC} can cause excessive heating and eventual destruction.
 4. The package thermal impedance is calculated in accordance with JESD 51-7.



electrical characteristics at specified free-air temperature, $V_{CC} = 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	T_A ‡	MIN	TYP	MAX	UNIT
V_{IO} Input offset voltage	$V_{CC} = 5\text{ V}$ to 30 V , $V_{IC} = V_{ICR}(\text{min})$, $V_O = 1.4\text{ V}$	25°C		1	2.5	mV
		Full range			5.5	
I_{IO} Input offset current	$V_O = 1.4\text{ V}$	25°C		5	50	nA
		Full range			150	
I_{IB} Input bias current	$V_O = 1.4\text{ V}$	25°C		-25	-250	nA
		Full range			-400	
V_{ICR} Common-mode input-voltage range		25°C		0 to $V_{CC}-1.5$		V
		Full range		0 to $V_{CC}-2$		
A_{VD} Large-signal differential-voltage amplification	$V_{CC} = 15\text{ V}$, $V_O = 1.4\text{ V}$ to 11.4 V , $R_L \geq 15\text{ k}\Omega$ to V_{CC}	25°C	50	200		V/mV
I_{OH} High-level output current	$V_{ID} = 1\text{ V}$	$V_{OH} = 5\text{ V}$ 25°C		0.1	50	nA
		$V_{OH} = 30\text{ V}$ Full range			1	μA
V_{OL} Low-level output voltage	$V_{ID} = -1\text{ V}$, $I_{OL} = 4\text{ mA}$	25°C		150	400	mV
		Full range			700	
I_{OL} Low-level output current	$V_{ID} = -1\text{ V}$, $V_{OL} = 1.5\text{ V}$	25°C	6	16		mA
I_{CC} Supply current (four comparators)	$V_O = 2.5\text{ V}$, No load	25°C		0.8	2	mA

† All characteristics are measured with zero common-mode input voltage, unless otherwise specified.

‡ Full range (MIN to MAX) for LM239AQ is -40°C to 125°C . All characteristics are measured with zero common-mode input voltage, unless otherwise specified.

switching characteristics, $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Response time	R_L connected to 5 V through $5.1\text{ k}\Omega$, $C_L = 15\text{ pF}$ §, See Note 5	100-mV input step with 5-mV overdrive		1.3	μs
		TTL-level input step		0.3	

§ C_L includes probe and jig capacitance.

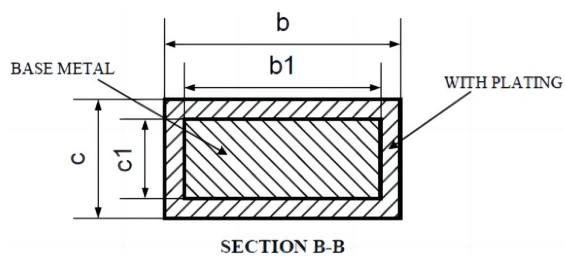
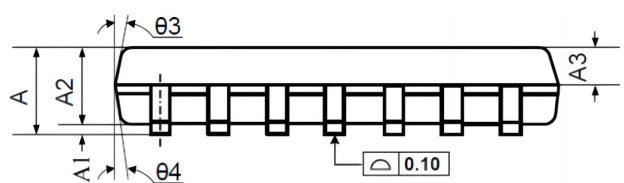
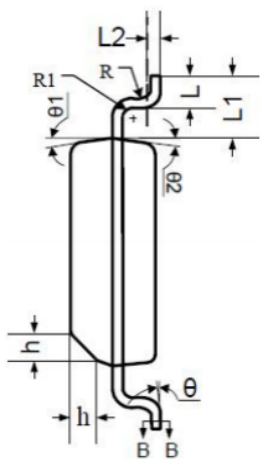
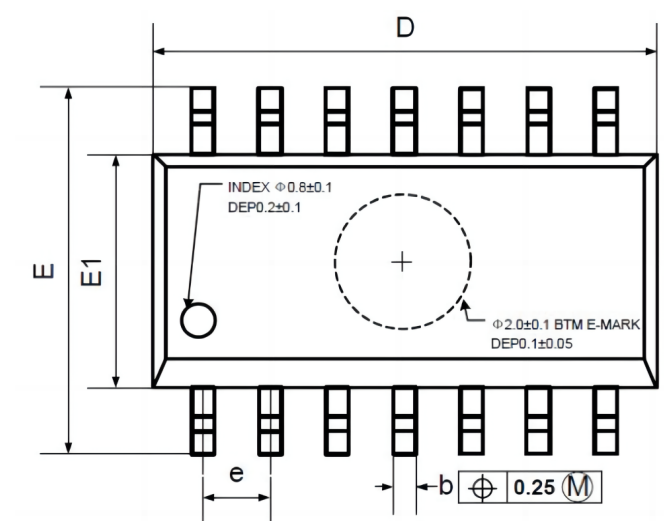
NOTE 5: The response time specified is the interval between the input step function and the instant when the output crosses 1.4 V .



ORDERING INFORMATION

Order Number	Package	Package Quantity	Temperature	Marking On The park
LM239AQDRQ1	SOP14	Tape,Reel,2500	-40°C to125°C	LM239AQ1

Package SOP14



Symbol	Dimensions In Millimeters		
	MIN	NOM	MAX
A	1.35	1.60	1.75
A1	0.10	0.15	0.25
A2	1.25	1.45	1.65
A3	0.55	0.65	0.75
b	0.36		0.49
b1	0.35	0.40	0.45
C	0.16		0.25
c1	0.15	0.20	0.25
D	8.53	8.63	8.73
E	5.80	6.00	6.20
E1	3.80	3.90	4.00
e	1.27 BSC		
L	0.45	0.60	0.80
L1	1.04 REF		
L2	0.25 BSC		
R	0.07		
R1	0.07		
h	0.30	0.40	0.50
θ	0°		8°
θ1	6°	8°	10°
θ2	6°	8°	10°
θ3	5°	7°	9°
θ4	5°	7°	9°



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